

SQS405EN-T1-GE3-VB Datasheet P-Channel 12 V (G-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
	0.015 at $V_{GS} = -4.5 \text{ V}$	- 25				
- 12	0.021 at V _{GS} = - 2.5 V	- 24	35 nC			
	0.023 at V _{GS} = - 1.8 V	- 24				

FEATURES

 Halogen-free according to IEC 61249-2-21 Definition



 Ultra Small DFN3x3 Chipscale Packaging Reduces Footprint Area, Profile (0.62 mm) and On-Resistance Per Footprint Area

Compliant to RoHS Directive 2002/95/EC



RoHS

Pin Description

Top View Bottom View

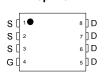


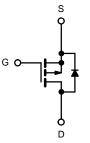
DFN3x3-8(punch type)

APPLICATIONS

- PA Switch
- Battery Switch
- · Load Switch

Top View





P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 12	V	
Gate-Source Voltage		V _{GS}	± 8	V
	T _C = 25 °C		- 25	
Continuous Proin Current (T. – 150 °C)	T _C = 70 °C		- 19	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 20 ^{b, c}	
	T _A = 70 °C		- 11 ^{b, c}	А
Pulsed Drain Current	I _{DM}	- 80		
0 11 0 0 0 1	T _C = 25 °C	1	- 26.7	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 3.5 ^{b, c}	
	T _C = 25 °C		37	
Mariana Barra Birahada	T _C = 70 °C	D	26	10/
Maximum Power Dissipation	T _A = 25 °C	P _D	3.9 ^{b, c}	W
	T _A = 70 °C		1.96 ^{b, c}	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 150	90	
Package Reflow Conditions ^d	IR/Convection		260	°C

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c t = 10 s
- d. Refer to IPC/JEDEC (J-STD-020), no manual or hand soldering.
- e. In this document, any reference to the Case represents the body of the DFN2X2 device and Foot is the bump.



THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, b}	R_{thJA}	31	42	°C/W			
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	13	16	C/ VV		

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 72 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	•		<u>'</u>				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 12			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		- 13.3		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1D = - 230 μΛ		2.4			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	- 0.5		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = 5 \text{ V}$			- 100	nA	
Zero Gate Voltage Drain Current	1	V _{DS} = - 12 V, V _{GS} = 0 V			- 1	μА	
Zero Gate voltage Drain Current	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 70 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 1 A		0.015		Ω	
Drain-Source On-State Resistance ^a		$V_{GS} = -2.5 \text{ V}, I_D = -1 \text{ A}$		0.021			
		V _{GS} = - 1.8 V, I _D = - 1 A		0.023			
Forward Transconductance ^a	9 _{fs}	V _{DS} = -4 V, I _D = -1 A		8.3		S	
Dynamic ^b							
Input Capacitance	C _{iss}			2220		pF	
Output Capacitance	C _{oss}	$V_{DS} = -6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		865			
Reverse Transfer Capacitance	C _{rss}			555		1	
Total Gate Charge	Qg	V _{DS} = -6 V, V _{GS} = -5 V, I _D = -1 A		38	57		
Total Gate Charge	₩g	V _{DS} = -6 V, V _{GS} = -4.5 V, I _D = -1 A		35	53	nC	
Gate-Source Charge	Q_{gs}			7.3			
Gate-Drain Charge	Q_{gd}			5.9			
Gate Resistance	R_g	$V_{GS} = -0.1 \text{ V, } f = 1 \text{ MHz}$		28		Ω	
Turn-On Delay Time	t _{d(on)}			14	21		
Rise Time	t _r	V_{DD} = - 6 V, R_L = 4 Ω		25	40	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \simeq -1$ A, $V_{GEN} = -4.5$ V, $R_g = 6$ Ω		380	570	113	
Fall Time	t _f			240	360		



SPECIFICATIONS T _J = 25 °C, unless otherwise noted								
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit		
Drain-Source Body Diode Characteristics								
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C		- 8		Α		
Pulse Diode Forward Current	I _{SM}			- 25		Α .		
Body Diode Voltage	V _{SD}	I _S = - 1 A, V _{GS} = 0 V		- 0.65	- 1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			311	467	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 1 A, dl/dt = 100 A/μs, T _{.I} = 25 °C		1.136	1.705	μC		
Reverse Recovery Fall Time	t _a	η η 1 Α, αιναι - 100 Ανμο, 1η - 25 ° Ο		116		ns		
Reverse Recovery Rise Time	t _b			195		110		

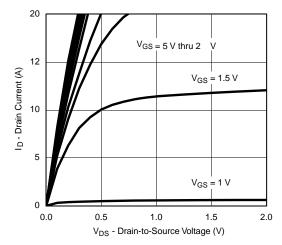
Notes:

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

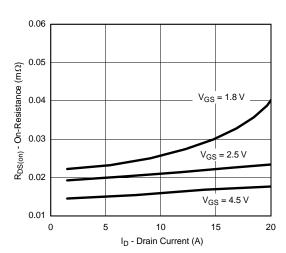
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



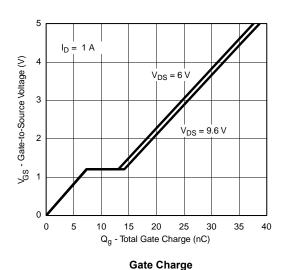
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Output Characteristics



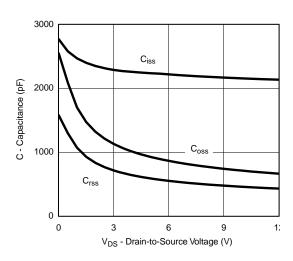
On-Resistance vs. Drain Current and Gate Voltage



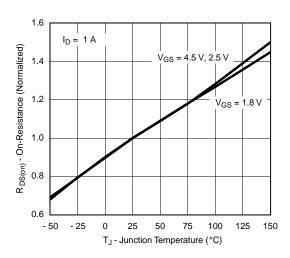
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Transfer Characteristics



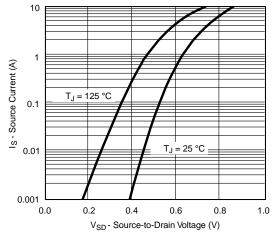
Capacitance



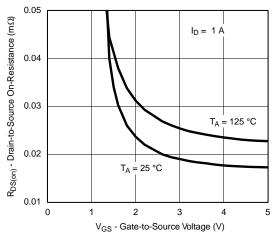
On-Resistance vs. Junction Temperature



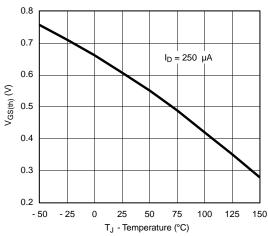
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



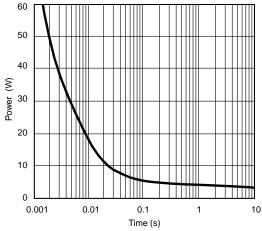
Source-Drain Diode Forward Voltage



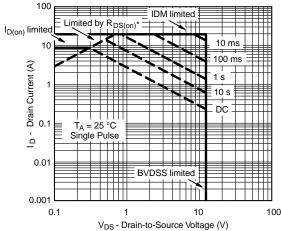
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

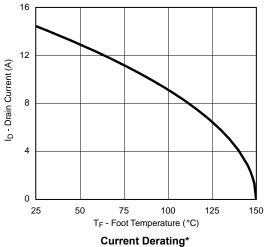


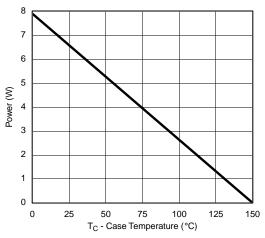
 * V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area, Junction-to-Ambient



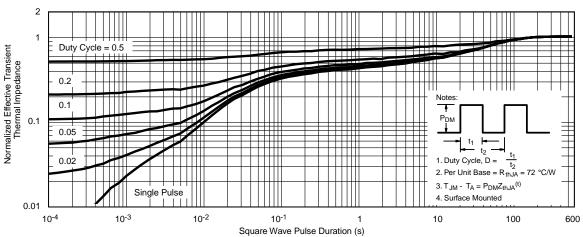
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



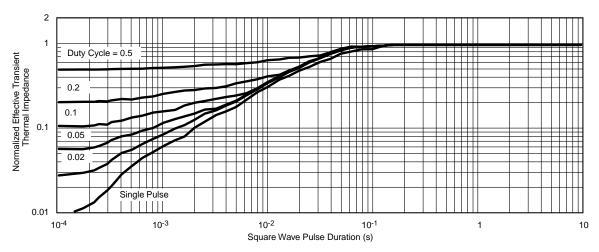


Current Derating

Power Derating



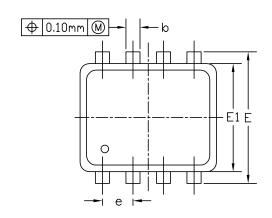
Normalized Thermal Transient Impedance, Junction-to-Ambient

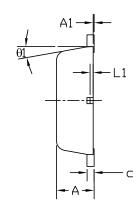


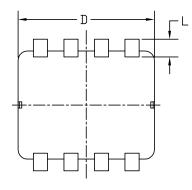
Normalized Thermal Transient Impedance, Junction-to-Foot



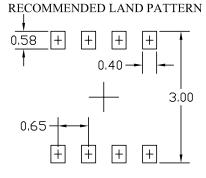
DFN3x3A_8L_NEP_P PACKAGE OUTLINE







BOTTOM VIEW



SYMBOLS	DIMENS	IONS IN MILLI	METERS	DIMENSIONS IN INCHES			
	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.70	0.80	0.90	0.028	0.031	0.035	
A1	0.00		0.05	0.000		0.002	
b	0. 24	0.30	0.35	0.009	0.012	0.014	
c	0.08	0. 15	0. 25	0.003	0.006	0.010	
D	2.80	2.90	3. 00	0.110	0.114	0.118	
Е	2.70	2.80	2. 90	0.106	0.110	0.114	
E1	2. 20	2.30	2.40	0.0087	0.091	0.095	
e	0.65 BSC			0.026 BSC			
L	0. 20	0.38	0.45	0.008	0.015	0.018	
L1	0.05		0.10	0.002		0.004	
θ1	0°	10°	12°	0°	10°	12°	

UNIT: mm

NOTE

- 1. PAKCAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MIL EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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